

July 1987

GENERAL DESCRIPTION

N-channel enhancement mode field-effect power transistor in a metal envelope.

This device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and DC/AC converters, and in general purpose switching applications.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | MAX. | UNIT |
|----------------------|----------------------------------|------|------|
| V _D S | Drain-source voltage | 1000 | V |
| I _D | Drain current (d.c.) | 4,5 | A |
| P _{TOT} | Total power dissipation | 125 | W |
| R _D S(ON) | Drain-source on-state resistance | 2,6 | Ω |

MECHANICAL DATA*Dimensions in mm*

Net mass: 12 g

Pinning:
1 = Gate
2 = Drain
3 = Source

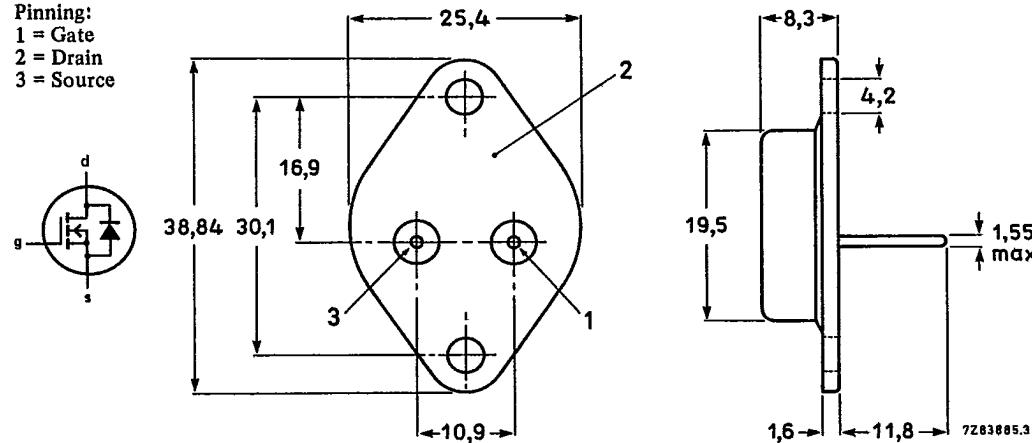


Fig.1 TO3; drain connected to mounting base.

Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Accessories supplied on request: refer to Mounting instructions for TO3 envelopes.

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RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|----------------------------------|--------------------------|------|------|------|
| V _{DS} | Drain-source voltage | — | — | 1000 | V |
| V _{DGR} | Drain-gate voltage | R _{GS} = 20 kΩ | — | 1000 | V |
| ±V _{GS} | Gate-source voltage | — | — | 20 | V |
| I _D | Drain current (d.c.) | T _{mb} = 25 °C | — | 4,5 | A |
| I _D | Drain current (d.c.) | T _{mb} = 100 °C | — | 2,8 | A |
| I _{DM} | Drain current (pulse peak value) | T _{mb} = 25 °C | — | 18 | A |
| P _{tot} | Total power dissipation | T _{mb} = 25 °C | — | 125 | W |
| T _{stg} | Storage temperature | — | -55 | 150 | °C |
| T _j | Junction temperature | — | — | 150 | °C |

THERMAL RESISTANCES

| | |
|--------------------------------|--------------------------------|
| From junction to mounting base | R _{th j-mb} = 1,0 K/W |
| From junction to ambient | R _{th j-a} = 35 K/W |

STATIC CHARACTERISTICST_{mb} = 25 °C unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------------------|----------------------------------|--|------|------|------|------|
| V _{(BR)DSS} | Drain-source breakdown voltage | V _{GS} = 0 V; I _D = 0,25 mA | 1000 | — | — | V |
| V _{GS(TO)} | Gate threshold voltage | V _{DS} = V _{GS} ; I _D = 1 mA | 2,1 | 3,0 | 4,0 | V |
| I _{DSS} | Zero gate voltage drain current | V _{DS} = 1000 V; V _{GS} = 0 V; T _j = 25 °C | — | 20 | 250 | μA |
| I _{DSS} | Zero gate voltage drain current | V _{DS} = 1000 V; V _{GS} = 0 V; T _j = 125 °C | — | 0,1 | 1,0 | mA |
| I _{GSS} | Gate source leakage current | V _{GS} = ±20 V; V _{DS} = 0 V | — | 10 | 100 | nA |
| R _{D(S(ON))} | Drain-source on-state resistance | V _{GS} = 10 V; I _D = 2,6 A | — | 2,3 | 2,6 | Ω |

DYNAMIC CHARACTERISTICST_{mb} = 25 °C unless otherwise specified

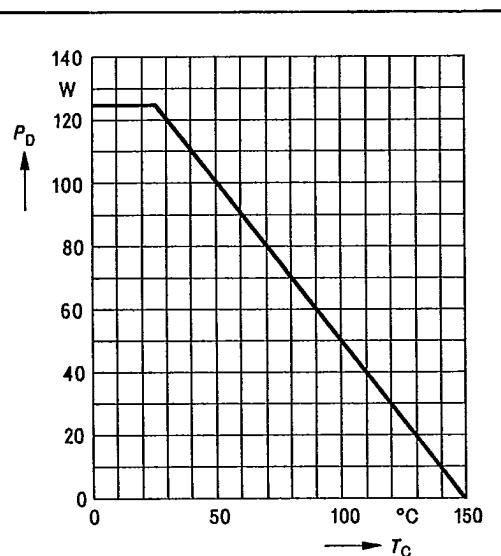
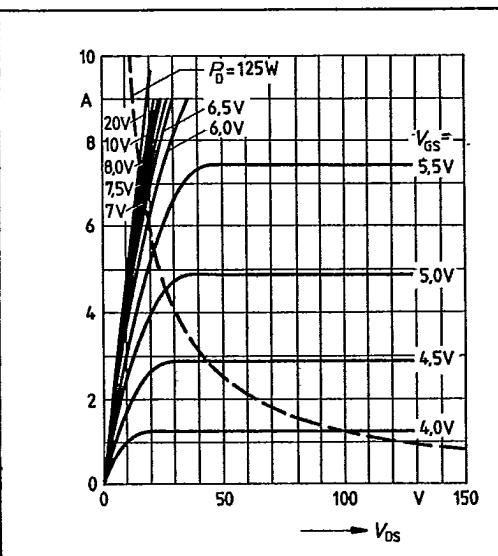
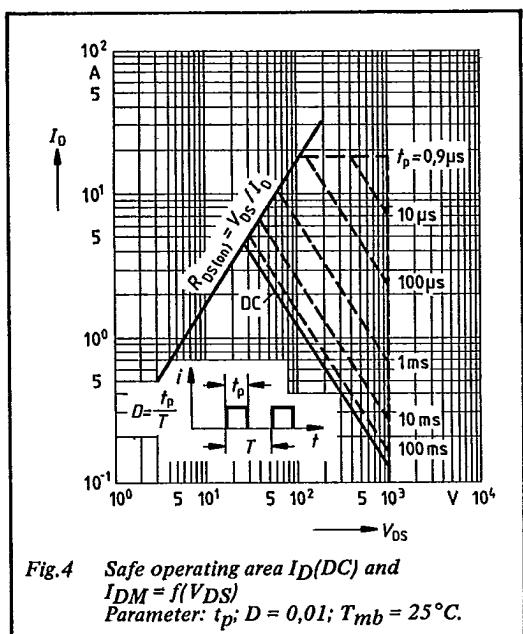
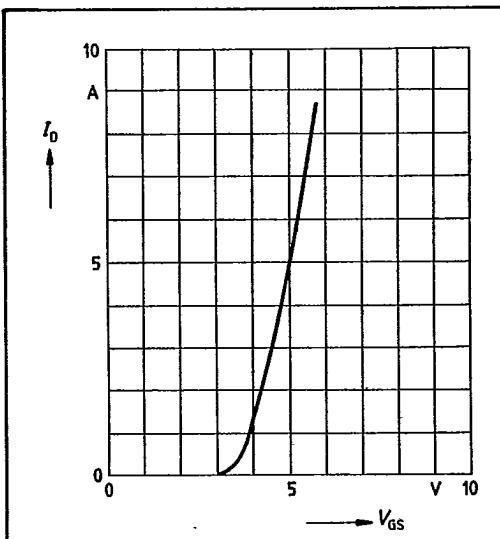
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------------|----------------------------|--|------|------|------|------|
| g _{fs} | Forward transconductance | V _{DS} = 25 V; I _D = 2,6 A | 1,4 | 3,5 | — | S |
| C _{iss} | Input capacitance | V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz | — | 3900 | 5000 | pF |
| C _{oss} | Output capacitance | | — | 180 | 300 | pF |
| C _{rss} | Feedback capacitance | | — | 60 | 90 | pF |
| t _{d on} | Turn-on delay time | V _{DD} = 30 V; I _D = 2,4 A; | — | 60 | 90 | ns |
| t _r | Turn-on rise time | V _{GS} = 10 V; R _{GS} = 50 Ω; | — | 90 | 140 | ns |
| t _{d off} | Turn-off delay time | R _{gen} = 50 Ω | — | 330 | 430 | ns |
| t _f | Turn-off fall time | | — | 110 | 140 | ns |
| L _d | Internal drain inductance | Measured from contact screw on header closer to source pin and centre of die | — | 5,0 | — | nH |
| L _s | Internal source inductance | Measured from source lead 6 mm from package to source bond pad | — | 12,5 | — | nH |

REVERSE DIODE RATINGS AND CHARACTERISTICS

 $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|----------------------|--|--|--------|------------|--------|---------------------|
| I_{DR} | Continuous reverse drain current | $T_{mb} = 25^\circ\text{C}$ | — | — | 4,5 | A |
| I_{DRM} | Pulsed reverse drain current | $T_{mb} = 25^\circ\text{C}$ | — | — | 18 | A |
| V_{SD} | Diode forward on-voltage | $I_F = 9 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$ | — | 1,5 | 1,4 | V |
| t_{rr} Q_{rr} | Reverse recovery time Reverse recovery charge | $I_F = 4,5 \text{ A}; T_j = 25^\circ\text{C}$ $-dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25^\circ\text{C};$ $V_{GS} = 0 \text{ V}; V_R = 100 \text{ V}$ | — — | 2000 30 | — — | ns μC |

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Fig.2 Power dissipation $P_D = f(T_{mb})$.Fig.3 Typical output characteristics $I_D = f(V_{DS})$
Parameter: V_{GS} ; 80 μ s pulse test;
 $T_{mb} = 25^\circ C$.Fig.4 Safe operating area $I_D(DC)$ and
 $I_{DM} = f(V_{DS})$
Parameter: $t_p; D = 0.01; T_{mb} = 25^\circ C$.Fig.5 Typical transfer characteristic $I_D = f(V_{GS})$
Conditions: 80 μ s pulse test; $V_{DS} = 25 V$,
 $T_{mb} = 25^\circ C$.

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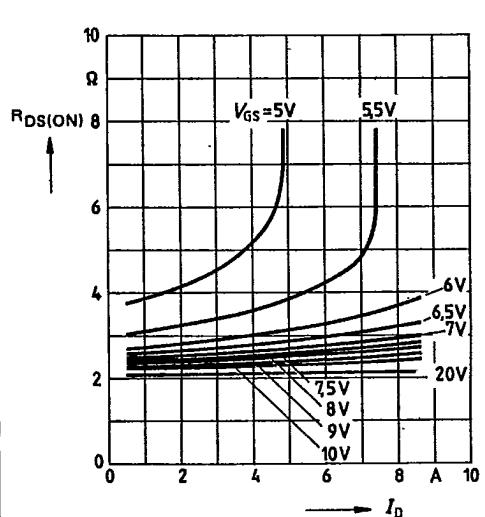


Fig.6 Typical drain-source on-state resistance
 $R_{DS(ON)} = f(I_D)$
Parameter: V_{GS} ; $T_j = 25^\circ C$.

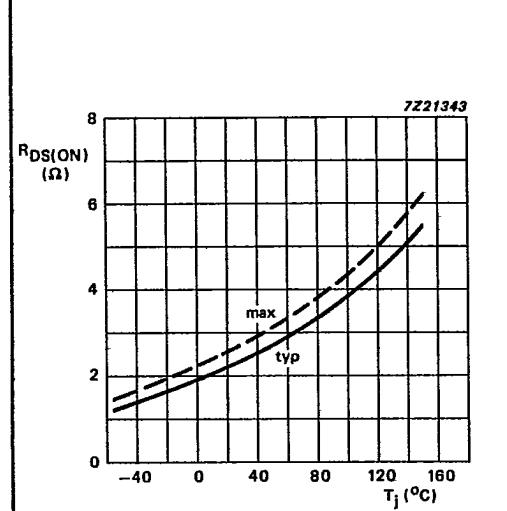


Fig.7 Drain-source on-state resistance
 $R_{DS(ON)} = f(T_j)$
Conditions: $I_D = 2, 6 A$; $V_{GS} = 10 V$.

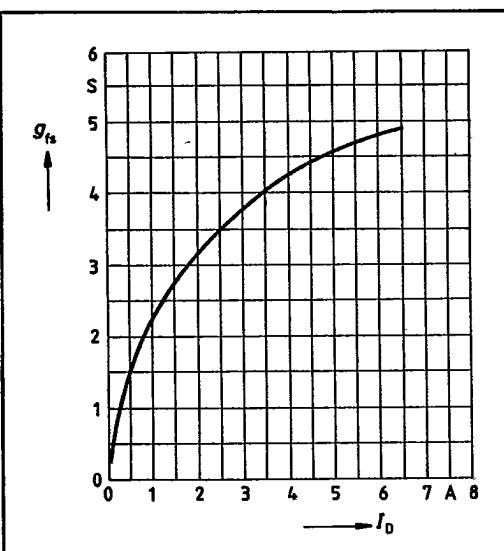


Fig.8 Typical transconductance $g_{fS} = f(I_D)$
Conditions: 80 μs pulse test;
 $V_{DS} = 25 V$; $T_j = 25^\circ C$.

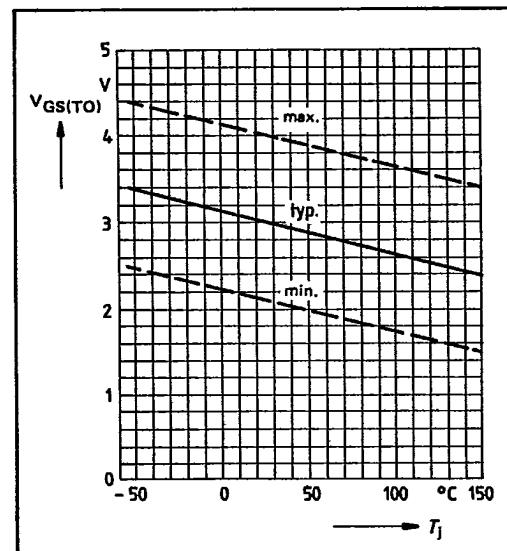


Fig.9 Gate threshold voltage $V_{GS(TO)} = f(T_j)$
Conditions: $V_{DS} = V_{GS}$; $I_D = 1 mA$.

PowerMOS transistor

BUZ54A

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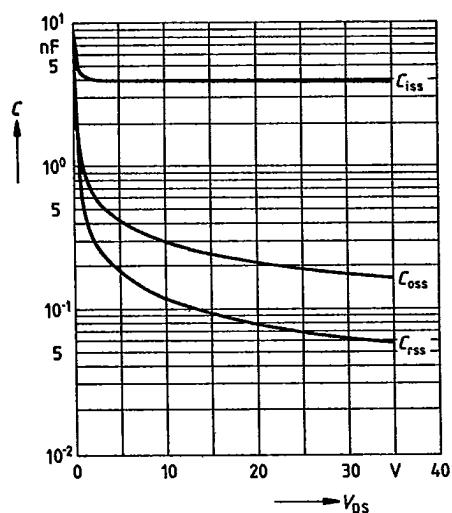


Fig.10 Typical capacitances $C = f(V_{DS})$
Conditions: $V_{GS} = 0$; $f = 1$ MHz.

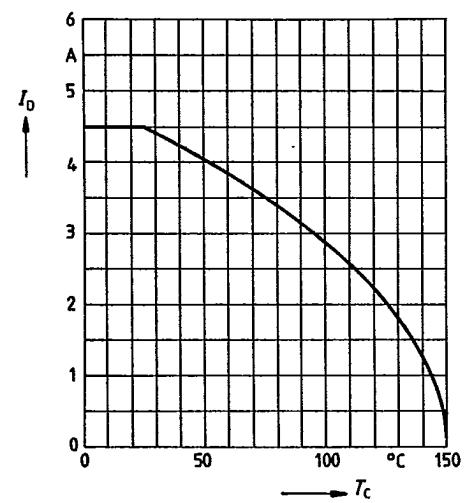


Fig.11 Continuous drain current $I_D = f(T_{mb})$
Conditions: $V_{GS} \geq 10$ V.

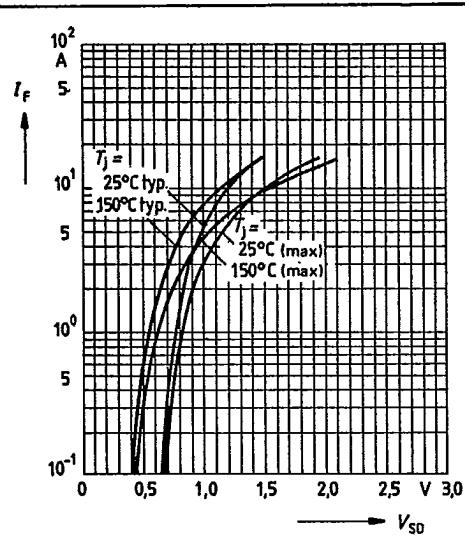


Fig.12 Forward characteristics of reverse diode
 $I_F = f(V_{SD})$
Parameter: T_j , $t_p = 80$ μ s.

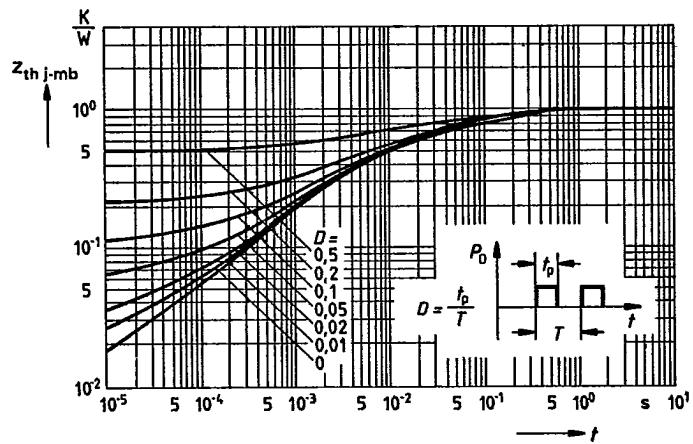


Fig.13 Transient thermal impedance $Z_{th\ j\ -mb} = f(t)$
Parameter: $D = t_p/T$.

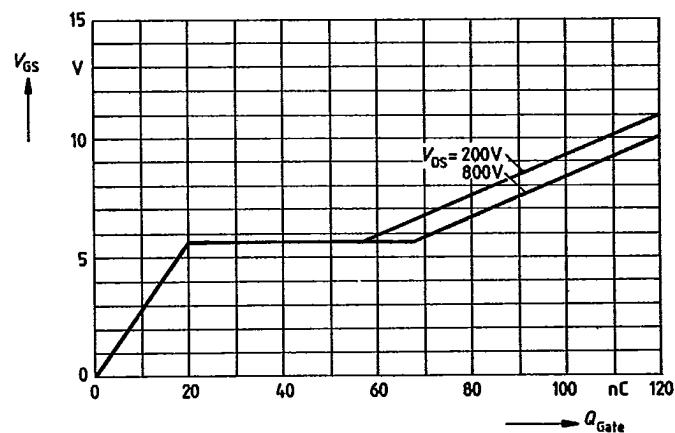


Fig.14 Typical gate-charge $V_{GS} = f(Q_{Gate})$
Parameter: V_{DS} ; $I_{DM} = 8,0\ A$.